TOSHIBA Field Effect Transistor Silicon N Channel MOS Type ($L^2-\pi$ -MOSV)

2SK2376

Chopper Regulator, DC–DC Converter and Motor Drive Applications

- 4-V gate drive
- Low drain-source ON resistance $: R_{DS} (ON) = 13 \text{ m}\Omega (typ.)$
- High forward transfer admittance $: |Y_{fs}| = 40 \text{ S} (typ.)$
- Low leakage current $: I_{DSS} = 100 \ \mu A \ (max) \ (V_{DS} = 60 \ V)$
- Enhancement mode $: V_{th} = 0.8 \sim 2.0 \text{ V} (V_{DS} = 10 \text{ V}, \text{ I}_{D} = 1 \text{ mA})$

Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Drain-source voltage		V _{DSS}	60	V	
Drain-gate voltage (R _{GS} = 20 kΩ)		V _{DGR}	60	V	
Gate-source voltage		V _{GSS}	±20	V	
Drain current	DC (Note 1)	۱ _D	45	А	
	Pulse (Note 1)	I _{DP}	180	А	
Drain power dissipatio	n (Tc = 25°C)	PD	100	W	
Single pulse avalanche energy (Note 2)		E _{AS}	701	mJ	
Avalanche current		I _{AR}	45	А	
Repetitive avalanche e	energy (Note 3)	E _{AR}	10	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

Thermal Characteristics

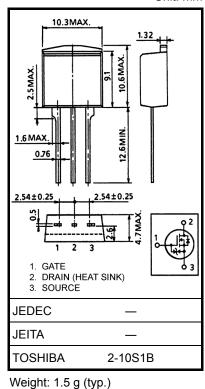
Characteristics	Symbol	Max	Unit	
Thermal resistance, channel to case	R _{th (ch-c)}	1.25	°C / W	
Thermal resistance, channel to ambient	R _{th (ch−a)}	83.3	°C / W	

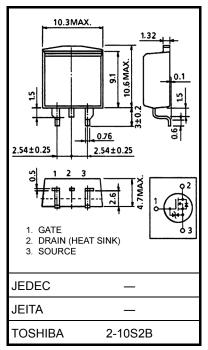
Note 1: Ensure that the channel temperature does not exceed 150°C.

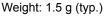
Note 2: V_{DD} = 25 V, T_{ch} = 25°C (initial), L = 471 µH, R_G = 25 Ω , I_{AR} = 45 A

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device. Please handle with caution.







Unit: mm

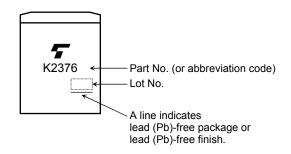
Electrical Characteristics (Ta = 25°C)

Charao	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit	
Gate leakage cu	ırrent	I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V		_	±10	μA	
Drain cut-off cu	rrent	I _{DSS}	V _{DS} = 60 V, V _{GS} = 0 V			100	μA	
Drain-source br	eakdown voltage	V (BR) DSS	I _D = 10 mA, V _{GS} = 0 V	60	_	_	V	
Gate threshold	voltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	0.8	_	2.0	V	
Drain-source ON resistance		R _{DS (ON)}	V _{GS} = 4 V, I _D = 25 A	_	19	25	- mΩ	
			V _{GS} = 10 V, I _D = 25 A		13	17		
Forward transfe	r admittance	Y _{fs}	V _{DS} = 10 V, I _D = 25 A	28	40		S	
Input capacitant	ce	C _{iss}			3350	_	pF	
Reverse transfer capacitance		C _{rss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz		550	_		
Output capacitance		Coss			1600	_		
Switching time	Rise time	tr	$v_{GS} \stackrel{10V}{}_{0V} \prod_{\substack{OU} \\ C \\ $	_	25	_		
	Turn-on time	t _{on}		_	55	_	20	
	Fall time	t _f		_	60	_	ns	
	Turn-off time	t _{off}	$\begin{array}{c} \text{VDD} \Rightarrow 30 \text{V}\\ \text{Duty} \leq 1\%, \ \text{t}_{W} = 10 \mu \text{s} \end{array}$	_	180	_		
Total gate charge (Gate-source plus gate-drain)		Qg		_	110	_		
Gate-source charge		Q _{gs}	V _{DD} ≈ 48 V, V _{GS} = 10 V, I _D = 45 A		70	—	nC	
Gate-drain ("miller") charge		Q _{gd}			40	—		

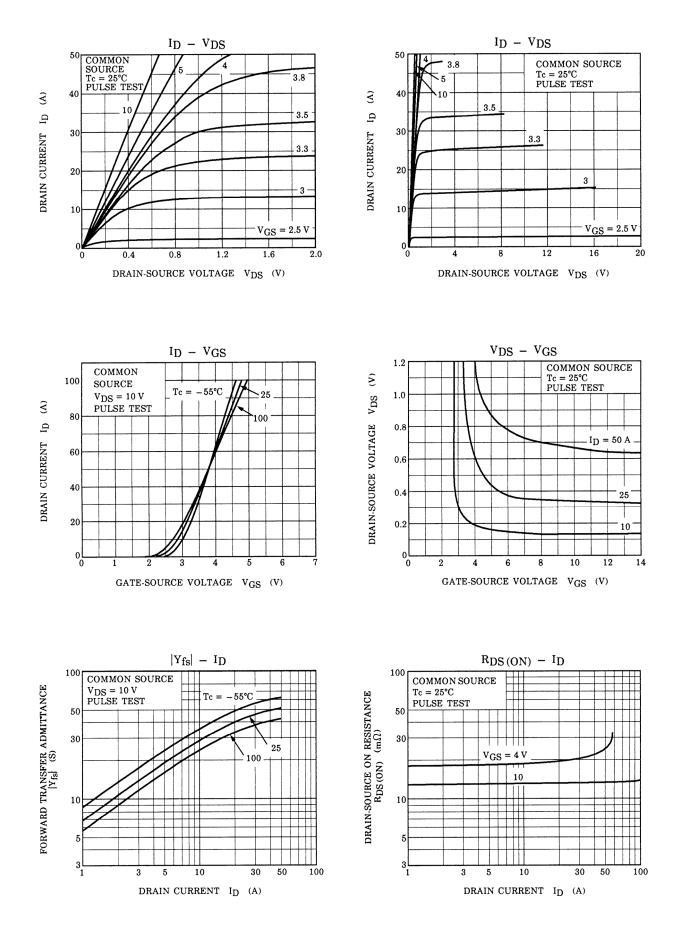
Source–Drain Ratings and Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	—	_	_	45	А
Pulse drain reverse current (Note 1)	I _{DRP}	_	_	_	180	A
Forward voltage (diode)	V _{DSF}	I _{DR} = 45 A, V _{GS} = 0 V	_	_	-1.7	V
Reverse recovery time	t _{rr}	I _{DR} = 45 A, V _{GS} = 0 V	_	120		ns
Reverse recovery charge	Q _{rr}	dI _{DR} / dt = 50 A / μs	_	0.2	_	μC

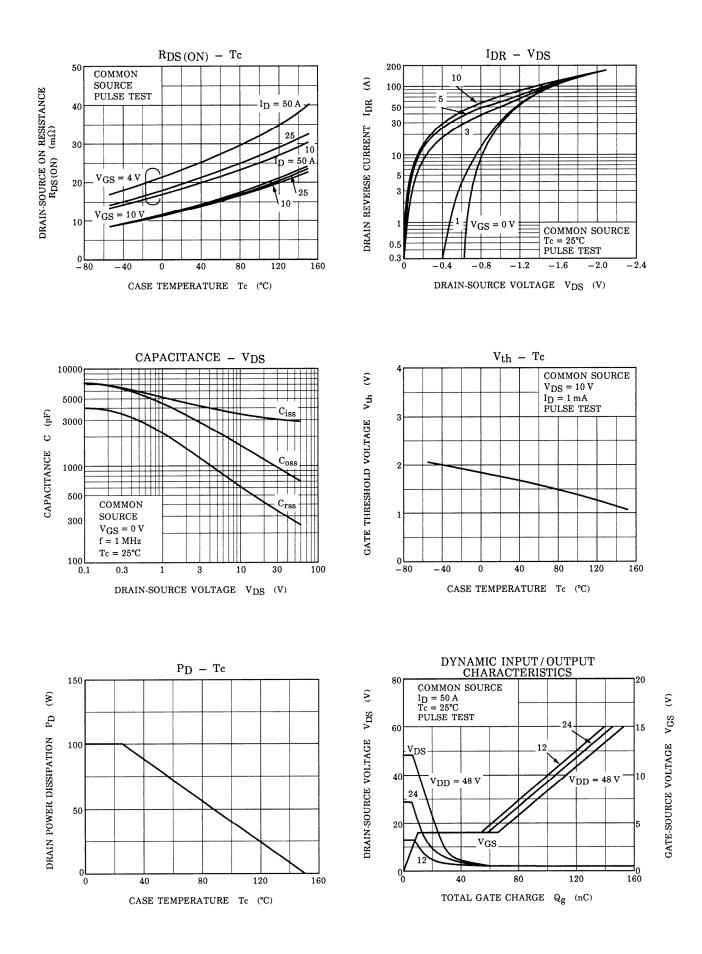
Marking



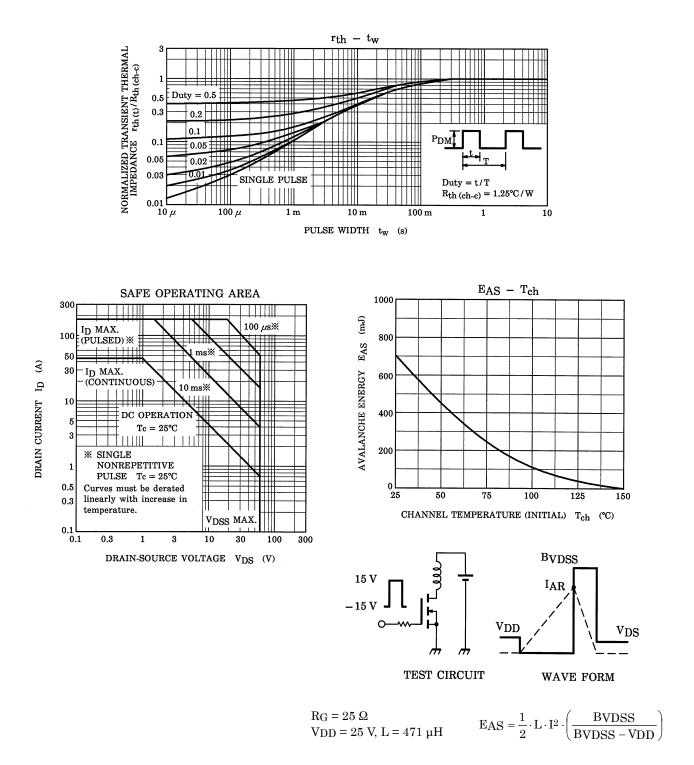
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